## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | KIM ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,172,729	01-2001	Ikeda, Munehiro	349/145
	В	US-2004/0201811	10-2004	Jun, Sahng-Ik	349/146
	C	ŪS-6,710,836	03-2004	Lee, Yun-Bok	349/141
	D	US-6,861,368	03-2005	Chae, Gee Sung	438/738
	E	US-2003/0133055	07-2003	Um et al.	349/43
	F	US-5,626,796	05-1997	Tsujimura et al.	252/582
	G	US-6,900,871	05-2005	Song et al.	349/139
	Н	US-6,897,909	05-2005	Ochiai et al.	349/43
	ı	US-6,633,360	10-2003	Okada et al.	349/145
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.